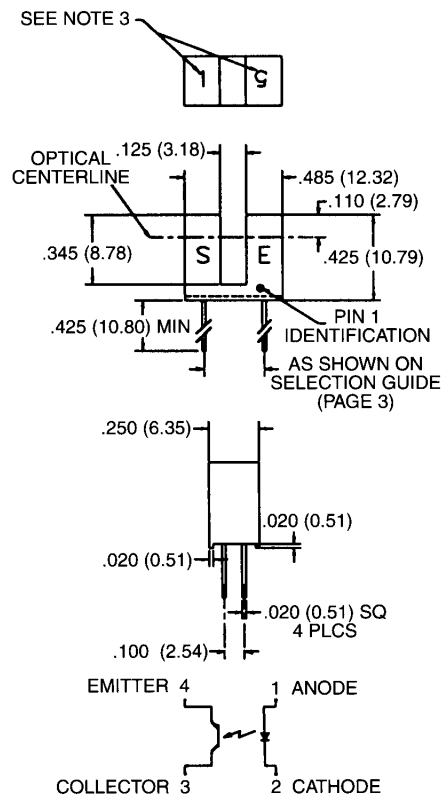


PACKAGE DIMENSIONS



ST2174

DESCRIPTION

The QVA series of switches is designed to allow the user maximum flexibility in applications. Each switch consists of an infrared emitting diode facing an NPN phototransistor across a .125" (3.18 mm) gap. A unique housing design provides a smooth external surface to prevent dust and dirt buildup while molded internal apertures give precise positioning and also provide protection from ambient light interference.

FEATURES

- Ambient light and dust protection.
- Lead spacing available at .220", .300", or .320".
- .010" and .050" apertures.

- NOTES:
1. DIMENSIONS ARE IN INCHES (mm).
 2. TOLERANCE IS $\pm .010$ (.25) UNLESS OTHERWISE SPECIFIED.
 3. NUMBER INDICATES APERTURE SIZE. (5 = .050", 1 = .010")

ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Specified)	
Storage Temperature	-40°C to $+85^\circ\text{C}$
Operating Temperature	-40°C to $+85^\circ\text{C}$
Soldering:	
Lead Temperature (Iron)	240°C for 5 sec. ^(2,3,4)
Lead Temperature (Flow)	260°C for 10 sec. ^(2,3)
INPUT DIODE	
Continuous Forward Current	50 mA
Reverse Voltage	5.0 Volts
Power Dissipation	100 mW ⁽¹⁾
OUTPUT TRANSISTOR	
Collector-Emitter Voltage	30.0 Volts
Emitter-Collector Voltage	5.0 Volts
Power Dissipation	100 mW ⁽¹⁾

ELECTRICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ Unless Otherwise Specified)						
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
INPUT DIODE						
Forward Voltage	V_F	—		1.70	V	$I_F = 20\text{ mA}$
Reverse Leakage Current	I_R	—		100	μA	$V_R = 2.0\text{ V}$
OUTPUT TRANSISTOR						
Emitter-Collector Breakdown	BV_{ECC}	5		—	V	$I_E = 100\ \mu\text{A}$, $E_e = 0$
Collector-Emitter Breakdown	BV_{CEO}	30		—	V	$I_C = 1.0\text{ mA}$, $E_e = 0$
Collector-Emitter Leakage	I_{CEO}	—		100	nA	$V_{CE} = 10.0\text{ V}$, $E_e = 0$
COUPLED						
On-State Collector Current	$I_{C(ON)}$	See selection guide page 3.			mA	$I_F = 20\text{ mA}$, $V_{CE} = 5\text{ V}$
Saturation Voltage	$V_{CE(SAT)}$	—		0.40	V	$I_F = 20\text{ mA}$, $I_C = 0.25\text{ mA}$

NOTES	
1. Derate power dissipation linearly 1.67 mW/°C above 25°C.	
2. RMA flux is recommended.	
3. Methanol or Isopropyl alcohols are recommended as cleaning agents.	
4. Soldering iron tip 1/16" (1.6 mm) from housing.	



SLOTTED OPTICAL SWITCH

QVAXXXX OPTICAL SWITCH SELECTION GUIDE						
PART NUMBER	LEAD SPACING	APERTURES		I_{LOW}		
		LED	SENSOR	MIN	MAX	
QVA11123	.220"	0.050"	0.010"	0.20	—	
QVA11124	.220"	0.050"	0.010"	0.50	—	
QVA11223	.300"	0.050"	0.010"	0.20	—	
QVA11224	.300"	0.050"	0.010"	0.50	—	
QVA11323	.320"	0.050"	0.010"	0.20	—	
QVA11324	.320"	0.050"	0.010"	0.50	—	
QVA11133	.220"	0.050"	0.050"	0.50	—	
QVA11134	.220"	0.050"	0.050"	1.00	—	
QVA11233	.300"	0.050"	0.050"	0.50	—	
QVA11234	.300"	0.050"	0.050"	1.00	—	
QVA11333	.320"	0.050"	0.050"	0.50	—	
QVA11334	.320"	0.050"	0.050"	1.00	—	
QVA21113	.220"	0.010"	0.010"	0.10	—	
QVA21114	.220"	0.010"	0.010"	0.20	—	
QVA21213	.300"	0.010"	0.010"	0.10	—	
QVA21214	.300"	0.010"	0.010"	0.20	—	
QVA21313	.320"	0.010"	0.010"	0.10	—	
QVA21314	.320"	0.010"	0.010"	0.20	—	



SLOTTED OPTICAL SWITCH

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